EXPRESS MAIL #EV417711460US **PATENT** LEC01 P429

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Peter M. Willis

For

: ANALYTICAL FURNACE WITH PREDICTIVE TEMPERATURE CONTROL

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

INFORMATION DISCLOSURE STATEMENT

In accordance with 37 CFR 1.51, 1.56, 1.97 and 1.98, Applicant hereby brings to the attention of the Office the patents, publications or other information listed on attached Form PTO 1449. One copy of each of the foreign patent documents and non-patent literature is enclosed herewith. All of the listed documents are in the English language.

This submission does not represent that a search has been made or that no better art exists and does not constitute an admission that each or all of the listed documents are material or constitute "prior art." If it should be determined that any of the listed documents do not constitute "prior art" under U.S. law, Applicant reserves the right to present to the Office the relevant facts and law regarding the appropriate status of such documents.

Applicant further reserves the right to take appropriate action to establish the patentability of the disclosed invention over the listed documents should one or more of the documents be applied against the claims of the present application. It is respectfully requested that each of the references be indicated as considered during the prosecution of the subject application. An action on the merits is solicited.

Respectfully submitted,

PETER M. WILLIS

By: Price, Heneveld, Cooper, DeWitt & Litton, LLP

March 2, 2004

Date

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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.